



**General Description**

- Trench Power AlphaSGT™ technology
- Low  $R_{DS(ON)}$
- Logic Level Driving
- Excellent  $Q_G \times R_{DS(ON)}$  Product (FOM)
- Skipe Optimized Process
- RoHS and Halogen-Free Compliant

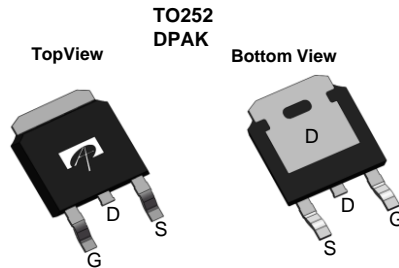
**Applications**

- High Frequency Switching and Synchronous Rectification

**Product Summary**

|                                  |                  |
|----------------------------------|------------------|
| $V_{DS}$                         | 100V             |
| $I_D$ (at $V_{GS}=10V$ )         | 70A              |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 8.2m $\Omega$  |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 10.7m $\Omega$ |

100% UIS Tested  
100% Rg Tested



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOD66920              | TO-252       | Tape & Reel | 2500                   |

**Absolute Maximum Ratings  $T_A=25^\circ\text{C}$  unless otherwise noted**

| Parameter                                      | Symbol         | Maximum                 | Units            |
|--|----------------|-------------------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$       | 100                     | V                |
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 20$                | V                |
| Continuous Drain Current <sup>G</sup>          | $I_D$          | 70                      | A                |
| Current <sup>G</sup>                           |                | $T_C=100^\circ\text{C}$ |                  |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$       | 180                     |                  |
| Continuous Drain Current                       | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | 19.5             |
|  |                | $T_A=70^\circ\text{C}$  | 15.5             |
| Avalanche Current <sup>C</sup>                 | $I_{AS}$       | 38                      | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}$       | 72                      | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$          | $T_C=25^\circ\text{C}$  | 89               |
|  |                | $T_C=100^\circ\text{C}$ | 35.5             |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 6.2              |
|  |                | $T_A=70^\circ\text{C}$  | 4.0              |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$ | -55 to 150              | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                  | Symbol          | Typ          | Max | Units              |
|--|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 15           | 20  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | Steady-State | 40  | 50                 |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 1.15         | 1.4 | $^\circ\text{C/W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min | Typ         | Max       | Units |
|-----------------------------|---------------------------------------|---|-----|-------------|-----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |             |           |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 100 |             |           | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =100V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                        |     |             | 1<br>5    | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  |     |             | ±100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 1.5 | 2.0         | 2.5       | V     |
| R <sub>DS(on)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                        |     | 6.7<br>11.6 | 8.2<br>14 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A  |     | 8.5         | 10.7      | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A  |     | 65          |           | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |     | 0.7         | 1         | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |     |             | 70        | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |             |           |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz   |     | 2500        |           | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |   |     | 485         |           | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |   |     | 13          |           | pF    |
| R <sub>g</sub>              | Gate resistance                       | f=1MHz  | 0.5 | 1.1         | 1.7       | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |             |           |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =20A                           |     | 35          | 50        | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |   |     | 16.7        | 25        | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |     | 8           |           | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |     | 5           |           | nC    |
| Q <sub>oss</sub>            | Output Charge                         | V <sub>GS</sub> =0V, V <sub>DS</sub> =50V   |     | 44          |           | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, R <sub>L</sub> =2.5Ω,<br>R <sub>GEN</sub> =3Ω |     | 10          |           | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |   |     | 4           |           | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |   |     | 31          |           | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |     | 6           |           | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, di/dt=500A/μs  |     | 34          |           | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, di/dt=500A/μs  |     | 170         |           | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

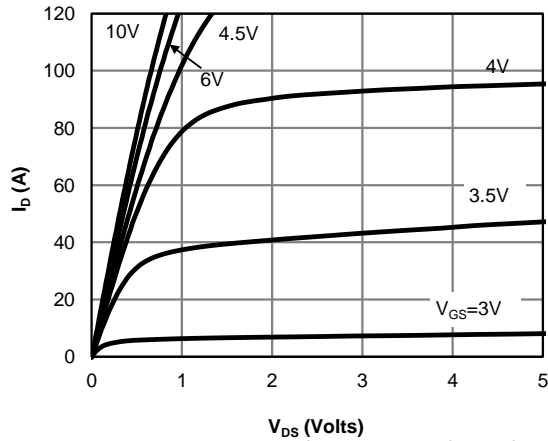
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

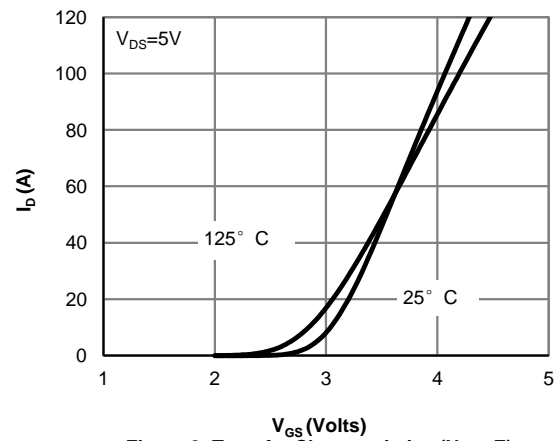
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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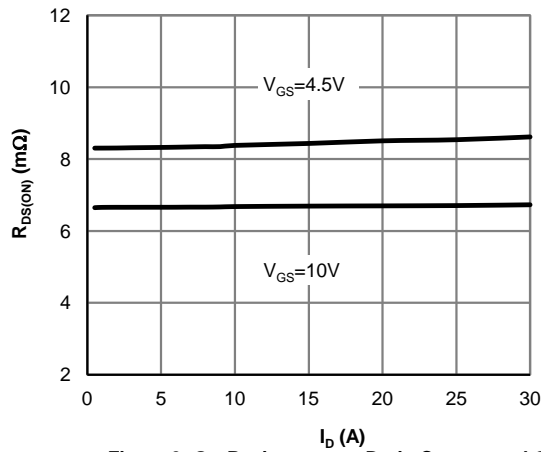
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



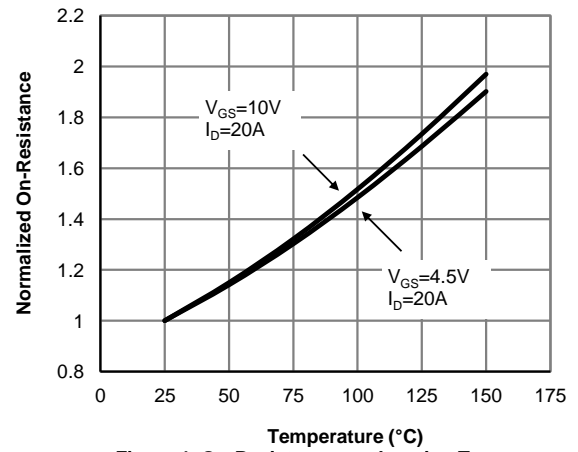
**Figure 1: On-Region Characteristics (Note E)**



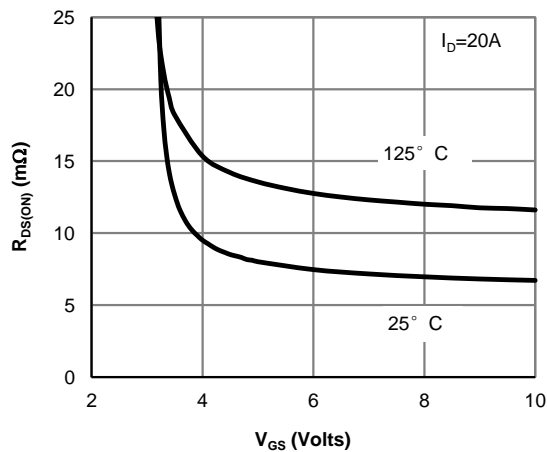
**Figure 2: Transfer Characteristics (Note E)**



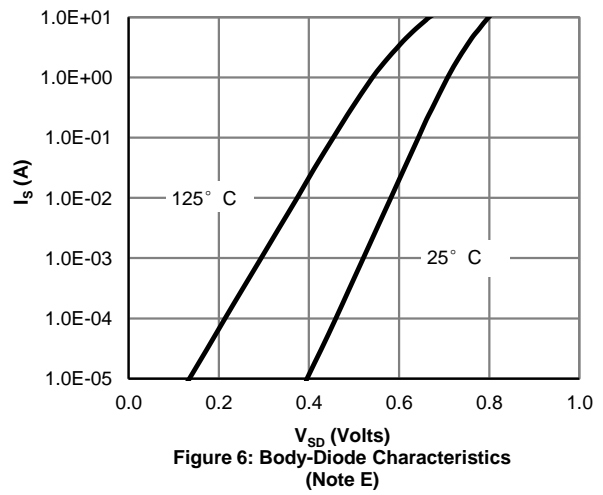
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

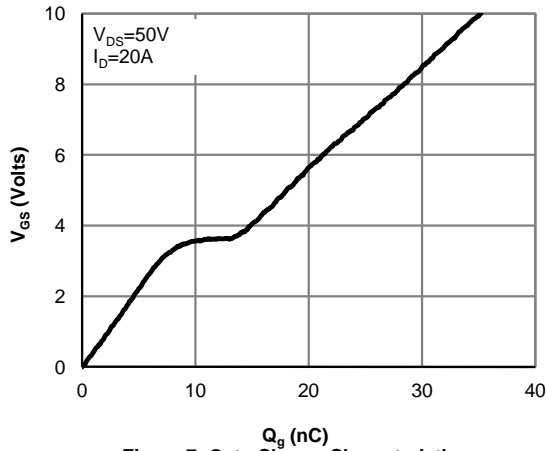


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

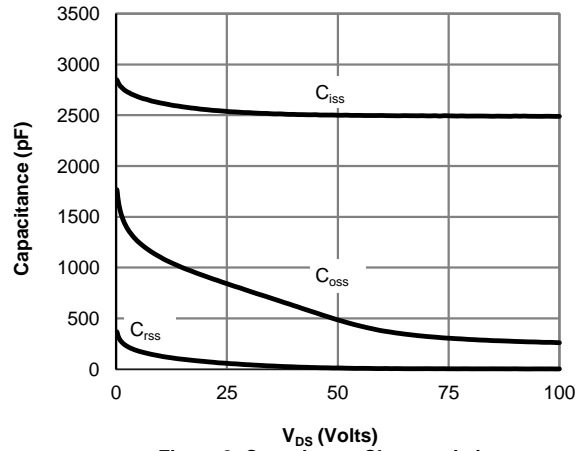


**Figure 6: Body-Diode Characteristics (Note E)**

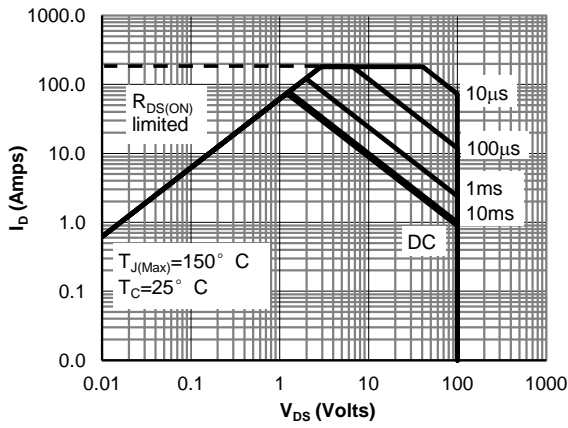
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



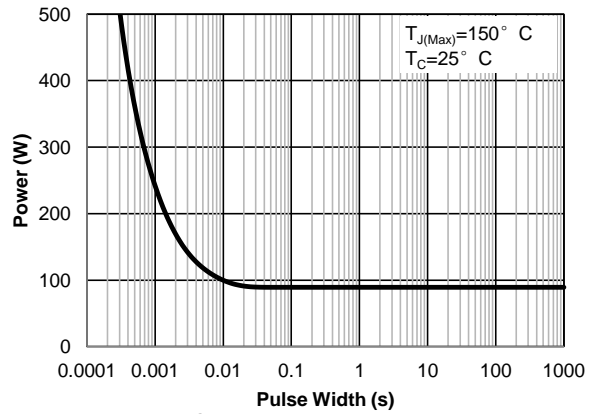
**Figure 7: Gate-Charge Characteristics**



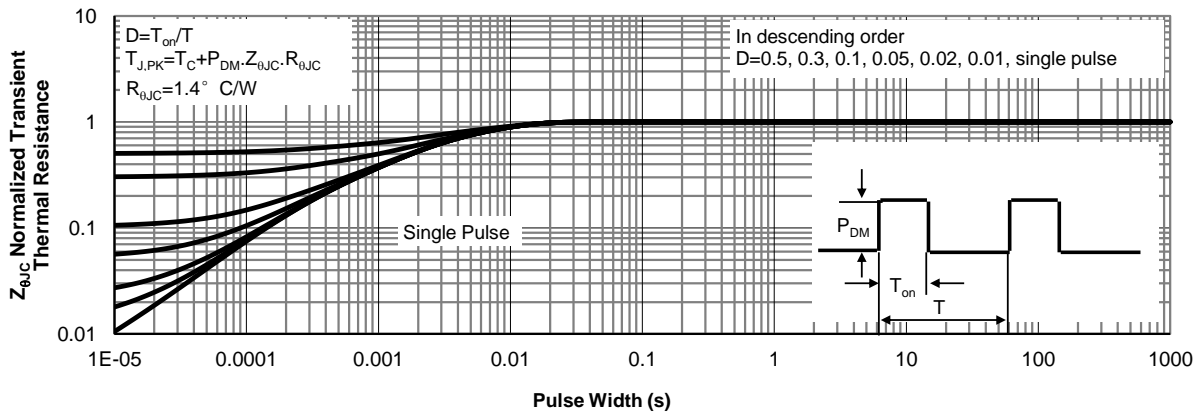
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

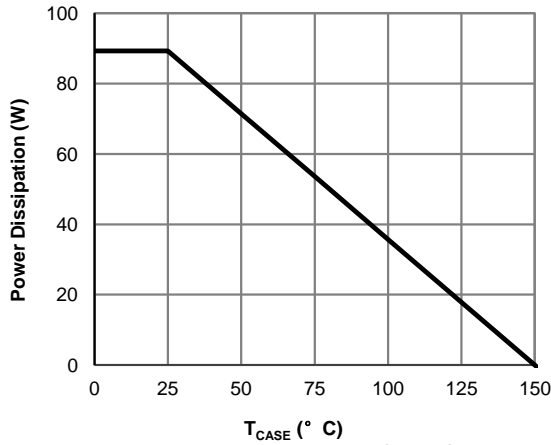


Figure 12: Power De-rating (Note F)

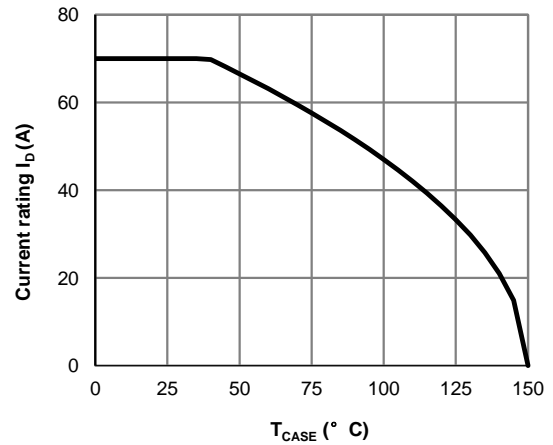


Figure 13: Current De-rating (Note F)

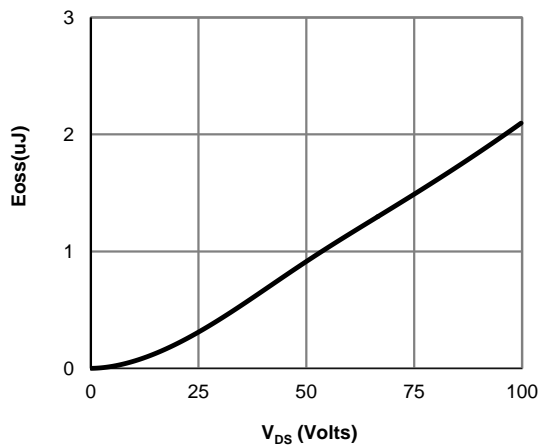


Figure 14: Coss stored Energy

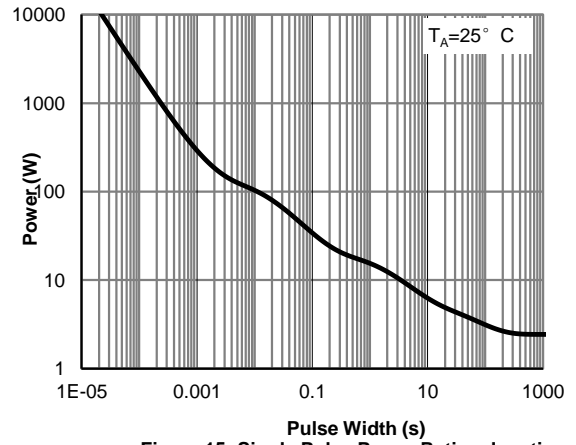


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

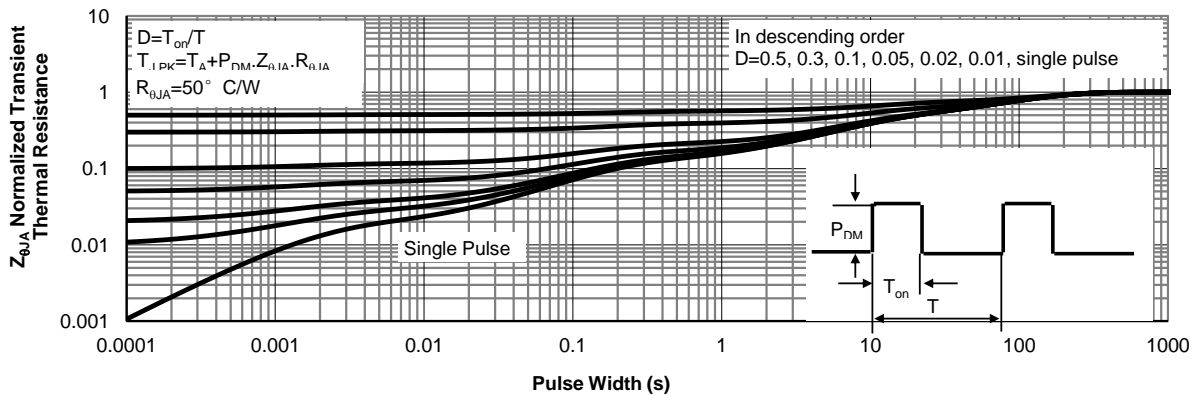


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

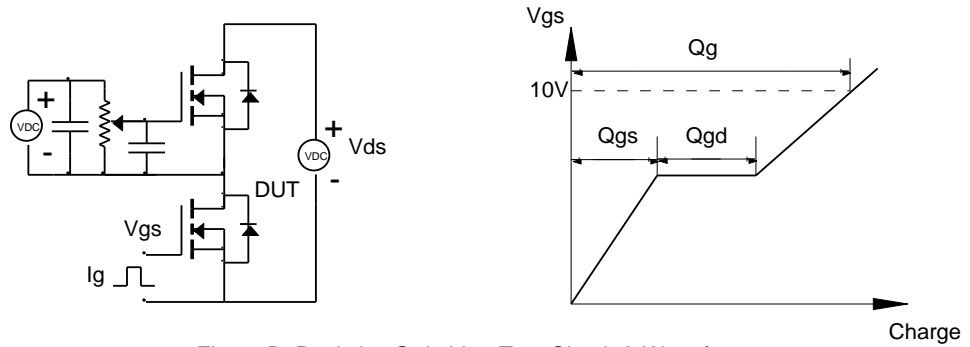


Figure B: Resistive Switching Test Circuit & Waveforms

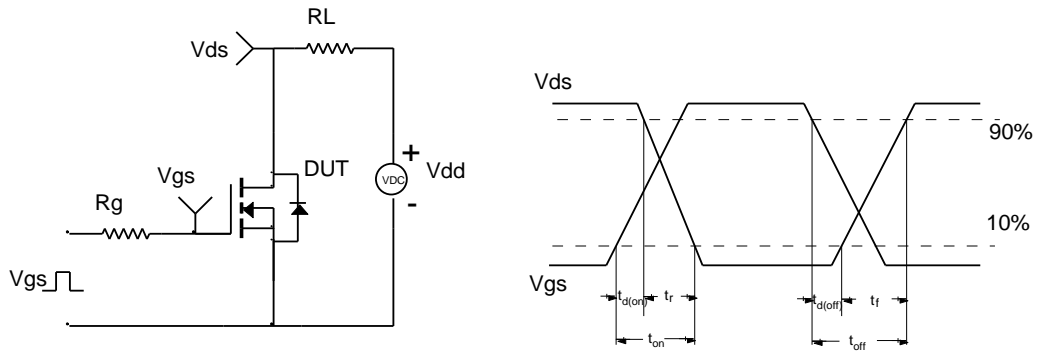


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

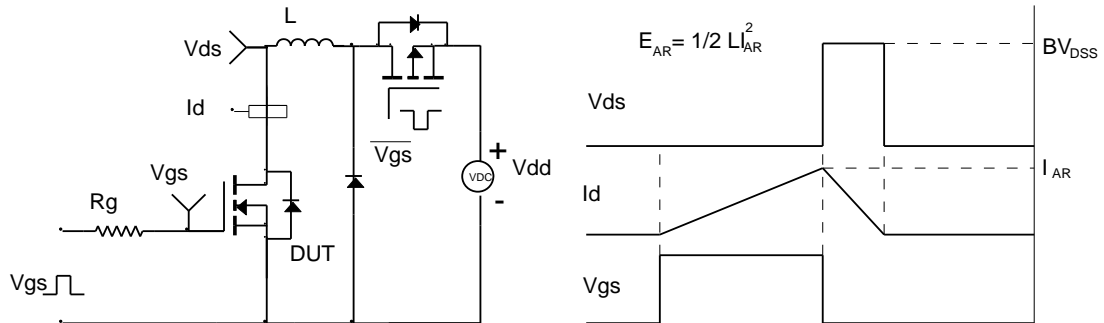


Figure D: Diode Recovery Test Circuit & Waveforms

